

FEATURES AND BENEFITS

- User-programmable field range:

 □ 6 to 8 mT □ 12 to 24 mT
- Preset differential magnetic field ranges:

 $\Box \pm 6 \text{ mT}$

- AEC-Q100 Grade 1 [1] automotive qualified (A variants only)
- Optimized for high dV/dt applications
- Differential sensing for stray-magnetic-field suppression
- Linear analog output voltage
- 1 MHz bandwidth
- Response time: < 300 nsSupply voltage: 3.3 or 5 V
- Low-noise performancePackage: 8-lead TSSOP

PACKAGE



Not to scale

8-lead TSSOF

APPLICATIONS

- Solar/power inverters
- Battery management systems
- Industrial equipment
- Power utility meters
- Power conditioner
- DC-DC converters

DESCRIPTION

The CT456 is a high-bandwidth and low-noise contactless current sensor that uses Allegro patented XtremeSense tunnel magnetoresistance (TMR) technology to enable high-accuracy current measurements for many consumer, enterprise, and industrial applications. The device supports a preprogramed 6 mT field range where the CT456 senses and translates the magnetic field into a linear analog output voltage.

The CT456 is also available in a user-programmable variant, which enables end-of-line calibration of gain and offset. While the sensor is preprogrammed to compensate for gain and offset temperature drift, the ability to adjust offset and gain relaxes mechanical tolerances during sensor mounting.

This contactless current sensor is not only small in size and simple to incorporate into a design, but it also provides effective common-mode rejection. Differential measurement enables the CT456 to have greater than 90% immunity to stray magnetic fields, which thus have almost no impact on the accuracy of the current measurement. The CT456 does not require an external core thanks to its high sensitivity and differential measurement.

The device has less than 300 ns output response time while the current consumption is ~6 mA. The CT456 is assembled in a low-profile, industry-standard eight-lead thin-shrink small-outline package (TSSOP) that is green and RoHS compliant.

FUNCTIONAL BLOCK DIAGRAM

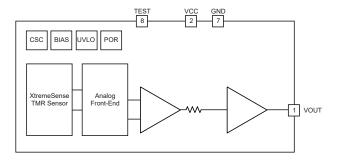


Figure 1: CT456 Functional Block Diagram for TSSOP-8

[1] For more details, see the Testing and Quality Assurance section.

CT456

XtremeSense™ TMR Differential Contactless Current Sensor with Programmable Gain

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SELECTION GUIDE

Part Number	Qualification	Polarity	Range (mT)	Supply Voltage (V)	Configuration	Operating Temperature Range (°C)	Package		
FACTORY-CALIBRA	FACTORY-CALIBRATED SENSORS								
CT456-A06B5-TS08	AEC-Q100 Grade 1	Dinalan	. 0	_	D:##1	40 += 405	8-lead TSSOP		
CT456-H06B5-TS08	-	Bipolar	±6	5	Differential	–40 to 125	3 mm × 6.4 mm × 1.1 mm		
PROGRAMMABLE	SENSORS								
CT456-A00B3-TS08	AEC-Q100 Grade 1	Bipolar		3.3					
CT456-H00B3-TS08	ı	Біроіаі	±6 to ±8 and	0.0					
CT456-A00B5-TS08	AEC-Q100 Grade 1	Bipolar	±12 to ±24		Differential	-40 to 125	8-lead TSSOP		
CT456-H00B5-TS08	-	Біроіаі		5	Dillerential	-40 to 125	3 mm × 6.4 mm × 1.1 mm		
CT456-A00U5-TS08	AEC-Q100 Grade 1	Unipolar	6 to 8 and	5					
CT456-H00U5-TS08	_	Unipolai	12 to 24						



ABSOLUTE MAXIMUM RATINGS [1]

Characteristic	Symbol	Notes	Rating	Unit
Supply Voltage	V _{CC}		-0.3 to 6	V
Analog Input/Output Pins, Maximum Voltage	V _{I/O}		-0.3 to (V _{CC} + 0.3) ^[2]	V
Electrostatic Discharge Protection Level	ESD	Human Body Model (HBM) per JESD22-A114	±2 (min)	kV
Electrostatic Discharge Protection Level	E9D	Charged Device Model (CDM) per JESD22-C101	±0.5 (min)	kV
Junction Temperature	T _J		-40 to 150	°C
Storage Temperature	T _{STG}		-65 to 155	°C
Lead Soldering Temperature	TL	10 seconds	260	°C
Magnetic Field	В	Magnetic field above this value can cause a permanent offset voltage drift	100	mT

^[1] Stresses exceeding the absolute maximum ratings may damage the CT456: The CT456 may not function or be operable at levels that exceed the recommended operating conditions, and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses that exceed the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.
[2] The lower of (V_{CC} + 0.3 V) or 6 V.

RECOMMENDED OPERATING CONDITIONS [1]

Characteristic	Symbol	Notes	Min.	Тур.	Max.	Unit
Supply Voltage Range	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	5 V _{CC} variant (-x5)	4.75	5	5.5	V
	V _{CC}	3.3 V _{CC} variant (-x3)	3	3.3	3.6	V
Output Voltage Range	V _{OUT}		0	_	V _{CC}	V
Output Current	I _{OUT}		_	_	±1	mA
Operating Ambient Temperature	T _A	Extended Industrial	-40	25	125	°C

^[1] The Recommended Operating Conditions table defines the conditions for actual operation of the CT456. Recommended operating conditions are specified to ensure optimal performance to the specifications. Allegro does not recommend exceeding them or designing to absolute maximum ratings.



APPLICATION DIAGRAM

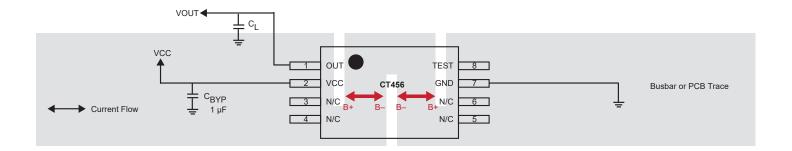


Figure 2: CT456 Application Diagram for Measuring Differential Magnetic Field for TSSOP-8



PINOUT DIAGRAM AND TERMINAL LIST

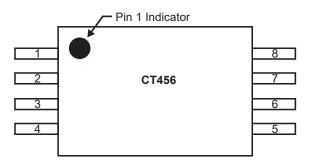


Figure 3: CT456 Pinout Diagram for Eight-Lead TSSOP (Top-Down View)

Terminal List

Number	Name	Function
1	OUT	Analog output voltage that represents the measured current/field.
2	VCC	Supply voltage.
3, 4, 5, 6	NC	No connect (leave floating).
7	GND	Ground.
8	TEST	Pin used for calibration. Connect to ground if not used.



ELECTRICAL CHARACTERISTICS: V_{CC} = 3 to 3.6 V or 4.75 to 5.5 V, T_A = -40°C to 125°C, C_{BYP} = 1 μ F, unless otherwise specified; typical values are V_{CC} = 3.3 or 5 V and T_A = 25°C

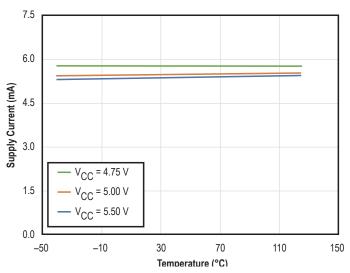
Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
POWER SUPPLIES	•		•			
Supply Current	I_{CC}	f _{BW} = 1 MHz, no load, B _{OP} = 0 mT	_	6	9	mA
OUT Maximum Drive Capability	I _{OUT}	OUT covers 10% to 90% of V _{CC} span	-1	-	1	mA
OUT Capacitive Load	C _L		_	-	100	pF
OUT Resistive Load	R_L		_	100	_	kΩ
Power Supply Rejection Ratio [1]	PSRR		_	35	_	dB
Sensitivity Power Supply Rejection Ratio [1]	SPSRR		-	35	-	dB
Offset Power Supply Rejection Ratio [1]	OPSRR		_	40	_	dB
Bandwidth [1]	f _{BW}	Small signal = -3 dB	_	1	_	MHz
ANALOG OUTPUT (OUT)			·			
OLIT Voltage Linear Bange	\/	5 V _{CC} variant (-x5)	0.5	-	4.5	V
OUT Voltage Linear Range	V _{OUT}	3.3 V _{CC} variant (-x3)	0.65	-	2.65	V
Output High Saturation Voltage	V _{OUT_SAT}	T _A = 25°C	V _{CC} - 0.3	V _{CC} - 0.25	_	V
TIMINGS			·			
Power-On Time	t _{ON}	$V_{CC} \ge 4 \text{ V variant (-x5)},$ $V_{CC} \ge 2.5 \text{ V variant (-x3)}$	_	100	200	μs
Rise Time [1]	t _{RISE}	B _{OP} = B _{RNG(MAX)} , T _A = 25°C, C _L = 100 pF	_	200	_	ns
Response Time [1]	t _{RESPONSE}	B _{OP} = B _{RNG(MAX)} , T _A = 25°C, C _L = 100 pF	_	300	_	ns
Propagation Delay [1]	t _{DELAY}	$B_{OP} = B_{RNG(MAX)}, T_A = 25^{\circ}C, C_L = 100 pF$	_	250	_	ns
PROTECTION						
Lindonyaltaga Lagiyayit		Rising V _{CC}	_	2.5	_	V
Undervoltage Lockout	V _{UVLO}	Falling V _{CC}	_	2.45	_	V
UVLO Hysteresis	V _{UV_HYS}		_	50	_	mV

^[1] Guaranteed by design and characterization; not tested in production.



ELECTRICAL CHARACTERISTICS

 V_{CC} = 3.3 or 5 V, T_A = 25°C, and C_{BYP} = 1 μF (unless otherwise specified)



7.5 6.0 Supply Current (mA) 4.5 3.0 $V_{CC} = 3.0 \text{ V}$ 1.5 V_{CC} = 3.3 V V_{CC} = 3.6 V 0.0 70 -50 -10 30 110 150 Temperature (°C)

Figure 4: 5 V_{CC} Variant (-x5) Supply Current vs. Temperature vs. Supply Voltage

Figure 5: 3.3 V_{CC} Variant (-x3) Supply Current vs. Temperature vs. Supply Voltage

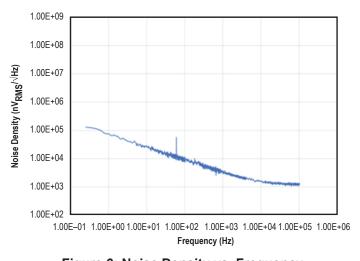


Figure 6: Noise Density vs. Frequency

CT456-x06B5: ± 6 mT – ELECTRICAL CHARACTERISTICS: [1][2] V_{CC} = 4.75 to 5.5 V, T_A = -40°C to 125°C, C_{BYP} = 1 μ F, unless otherwise specified; typical values are V_{CC} = 5 V and T_A = 25°C

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Differential Magnetic Field Range	B _{RNG}		-6	_	6	mT
Voltage Output Quiescent	V _{OQ}		_	2.5	-	V
Sensitivity	S		_	333.3	-	mV/mT
Bandwidth [3]	f _{BW}	Small signal = –3 dB	_	1	_	MHz
Noise	e _N	T _A = 25°C, f _{BW} = 100 kHz	_	3	_	μT _{RMS}
OUT ACCURACY PERFORMANCE						
Linearity Error	E _{LIN}	$B_{OP} = B_{OP(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.1	_	% FS
Sanaitivity Tamparatura Drift	_	$B_{OP} = B_{OP(MAX)}, T_A = 25^{\circ}C \text{ to } 125^{\circ}C$	_	±1.4	_	%
Sensitivity Temperature Drift	E _{SENS_Tdrift}	$B_{OP} = B_{OP(MAX)}$, $T_A = 25^{\circ}C$ to $-40^{\circ}C$	_	±1.6	_	%
Offset Voltage Error	V _{OE}	B _{OP} = 0 mT, T _A = 25°C	_	±4	_	mV
Officet Voltage Temperature Drift	\/	B _{OP} = 0 mT, T _A = 25°C to 125°C	_	±15	-	mV
Offset Voltage Temperature Drift	V _{OE_Tdrift}	B _{OP} = 0 mT, T _A = 25°C to -40°C	_	±26	-	mV
LIFETIME DRIFT						
Sensitivity Error Including Lifetime Drift	E _{SENS(DRIFT)}	$B_{OP} = B_{OP(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±3	_	%
Offset Voltage Error Including Lifetime Drift	V _{OE(DRIFT)}	$B_{OP} = 0 \text{ mT}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$	_	±34	_	mV

^[1] Typical (typ) values are the mean ±3 sigma of a test sample population. These are formatted as mean ±3 sigma.



^[2] Lifetime drift characteristics are based on a statistical combination of production distributions and the worst-case distribution of parametric drift of individuals observed during AEC-Q100 qualification.

^[3] Guaranteed by design and characterization. Not tested in production.

CT456-x00B5: Programmable Gain – ELECTRICAL CHARACTERISTICS: [1][2][3] V_{CC} = 4.75 to 5.5 V, T_A = -40°C to 125°C, C_{BYP} = 1 μ F, unless otherwise specified; typical values are V_{CC} = 5 V and T_A = 25°C

Characteristics Symbol **Test Conditions** Min. Тур. Max. Unit ±6 ±8 mT Programmable Differential Magnetic Field Range **B**PRNG ±12 ±24 mT Voltage Output Quiescent V_{OQ} _ 2.5 V _ Maximum Programmable Sensitivity 333.3 mV/mT SPMAX Minimum Programmable Sensitivity 41.7 mV/mT S_{PMIN} Bandwidth [4] MHz Small signal = -3 dB 1 f_{BW} $T_A = 25$ °C, $f_{BW} = 100 \text{ kHz}$, S = 41.7 mV/mTNoise 4 μT_{RMS} OUT ACCURACY PERFORMANCE [5] Linearity Error $\mathsf{E}_{\mathsf{LIN}}$ $B_{OP} = B_{OP(MAX)}$, $T_A = -40$ °C to 125°C ±0.3 % FS $B_{OP} = B_{OP(MAX)}$, $T_A = 25$ °C to 125°C ±1.4 % Sensitivity Temperature Drift $\mathsf{E}_{\mathsf{SENS_Tdrift}}$ $B_{OP} = B_{OP(MAX)}$, $T_A = 25$ °C to -40°C ±2.2 % _ $B_{OP} = 0 \text{ mT}, T_A = 25^{\circ}\text{C}$ Offset Voltage Error V_{OE} ±4 mV $B_{OP} = 0$ mT, $T_A = 25$ °C to 125°C ±15 mV Offset Voltage Temperature Drift V_{OE_Tdrift} $B_{OP} = 0 \text{ mT}, T_A = 25^{\circ}\text{C to } -40^{\circ}\text{C}$ ±26 mV LIFETIME DRIFT [5] Sensitivity Error Including Lifetime Drift E_{SENS(DRIFT)} $B_{OP} = B_{OP(MAX)}$, $T_A = -40$ °C to 125°C ±3 % $B_{OP} = 0 \text{ mT}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$ Offset Voltage Error Including Lifetime Drift ±34 mV V_{OE(DRIFT)}



^[1] Tested on TSSOP package

^[2] Typical (typ) values are the mean ±3 sigma of a test sample population. These are formatted as mean ±3 sigma.

^[3] Lifetime drift characteristics are based on a statistical combination of production distributions and the worst-case distribution of parametric drift of individuals observed during AEC-Q100 qualification.

^[4] Guaranteed by design and characterization. Not tested in production.

^[5] Linearity and sensitivity temperature drift performance vary as a function of the sensitivity programmed. Errors are smaller when sensitivity is closer to the 6 mT version.

CT456-x00B3: Programmable Gain – ELECTRICAL CHARACTERISTICS: [1][2] V_{CC} = 3 to 3.6 V, T_A = -40°C to 125°C,

 C_{BYP} = 1 μF , unless otherwise specified; typical values are V_{CC} = 3.3 V and T_A = 25 $^{\circ}C$

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Programmable Differential Magnetic Field Range	B		±6	_	±8	mT
Programmable Differential Magnetic Field Name	B _{PRNG}		±12	_	±24	mT
Voltage Output Quiescent	V _{OQ}		_	1.65	_	٧
Maximum Programmable Sensitivity	S _{PMAX}		_	166.7	_	mV/mT
Minimum Programmable Sensitivity	S _{PMIN}		_	20.8	_	mV/mT
Bandwidth [3]	f _{BW}	Small signal = -3 dB	_	1	_	MHz
Noise	e _N	T _A = 25°C, f _{BW} = 100 kHz, S = 166 mV/mT	_	4	_	μT _{RMS}
OUT ACCURACY PERFORMANCE [4]						
Linearity Error	E _{LIN}	$B_{OP} = B_{OP(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.3	_	% FS
Consistivity Townsers turn Drift	_	$B_{OP} = B_{OP(MAX)}, T_A = 25^{\circ}C \text{ to } 125^{\circ}C$	_	±1.4	_	%
Sensitivity Temperature Drift	E _{SENS_Tdrift}	$B_{OP} = B_{OP(MAX)}$, $T_A = 25$ °C to -40 °C	_	±2.2	_	%
Offset Voltage Error	V _{OE}	B _{OP} = 0 mT, T _A = 25°C	_	±4	_	mV
Officet Voltage Temperature Drift		B _{OP} = 0 mT, T _A = 25°C to 125°C	_	±13	_	mV
Offset Voltage Temperature Drift	V _{OE_Tdrift}	B _{OP} = 0 mT, T _A = 25°C to -40°C	_	±15	_	mV
LIFETIME DRIFT [4]						
Sensitivity Error Including Lifetime Drift	E _{SENS(DRIFT)}	$B_{OP} = B_{OP(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±3	_	%
Offset Voltage Error Including Lifetime Drift	V _{OE(DRIFT)}	$B_{OP} = 0 \text{ mT}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$	_	±20	_	mV

^[1] Typical values are the mean ±3 sigma of a test sample population. These are formatted as mean ±3 sigma.



^[2] Lifetime drift characteristics are based on a statistical combination of production distributions and the worst-case distribution of parametric drift of individuals observed during AEC-Q100 qualification.

^[3] Guaranteed by design and characterization. Not tested in production.

^[4] Linearity and sensitivity temperature drift performance vary as a function of the sensitivity programmed. Errors are smaller when sensitivity is closer to the 6 mT version.

CT456-x00U5: Programmable Gain – ELECTRICAL CHARACTERISTICS: [1][2] V_{CC} = 4.75 to 5.5 V, T_A = -40°C to 125°C, C_{BYP} = 1 μ F, unless otherwise specified; typical values are V_{CC} = 5 V and T_A = 25°C

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Programmable Differential Magnetic Field Bange	D		0 to 6	_	0 to 8	mT
Programmable Differential Magnetic Field Range	B _{PRNG}		0 to 12	_	0 to 24	mT
Voltage Output Quiescent	V _{OQ}		_	0.5	_	V
Maximum Programmable Sensitivity	S _{PMAX}		_	666.7	_	mV/mT
Minimum Programmable Sensitivity	S _{PMIN}		_	83.3	_	mV/mT
Bandwidth [3]	f _{BW}	Small signal = -3 dB	_	1	_	MHz
Noise	e _N	T _A = 25°C, f _{BW} = 100 kHz, S = 83.3 mV/mT	_	3	_	μT _{RMS}
OUT ACCURACY PERFORMANCE [4]	*					
Linearity Error	E _{LIN}	$B_{OP} = B_{OP(MAX)}, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.3	_	% FS
Sensitivity Temperature Drift	_	$B_{OP} = B_{OP(MAX)}$, $T_A = 25$ °C to 125°C	_	±1.4	_	%
Sensitivity remperature Diffit	E _{SENS_Tdrift}	$B_{OP} = B_{OP(MAX)}$, $T_A = 25^{\circ}C$ to $-40^{\circ}C$	_	±2.2	_	%
Offset Voltage Error	V _{OE}	B _{OP} = 0 mT, T _A = 25°C	_	±7	_	mV
Offset Voltage Temperature Drift	\/	B _{OP} = 0 mT, T _A = 25°C to 125°C	_	±11	_	mV
Oliset Voltage Temperature Diffit	V _{OE_Tdrift}	$B_{OP} = 0 \text{ mT}, T_A = 25^{\circ}\text{C to } -40^{\circ}\text{C}$	_	±25	_	mV
LIFETIME DRIFT [4]						
Sensitivity Error Including Lifetime Drift	E _{SENS(DRIFT)}	$B_{OP} = B_{OP(MAX)}$, $T_A = -40$ °C to 125°C	_	±3	_	%
Offset Voltage Error Including Lifetime Drift	V _{OE(DRIFT)}	$B_{OP} = 0 \text{ mT}, T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$	_	±32	_	mV

^[1] Typical (typ) values are the mean ±3 sigma of a test sample population. These are formatted as mean ±3 sigma.



^[2] Lifetime drift characteristics are based on a statistical combination of production distributions and the worst-case distribution of parametric drift of individuals observed during AEC-Q100 qualification.

^[3] Guaranteed by design and characterization. Not tested in production.

^[4] Linearity and sensitivity temperature drift performance vary as a function of the sensitivity programmed. Errors are smaller when sensitivity is closer to the 6 mT version.

Calibration Description

The CT456-x00 is factory-trimmed for sensitivity and offset temperature drift. The sensor provides the ability to adjust gain to allow for all the mechanical tolerances during manufacturing. Gain calibration is recommended to be performed at room temperature (25°C) using the LabView and NI PXI solution.

Device Programming

COMMUNICATION

The programmable versions of the device allow customization of the sensitivity and offset voltage. These devices use a one-time programming (OTP) method, and parameters can be adjusted through test modes (volatile) before permanent programming.

The test mode allows an external controller to read, write, and program the device. The device enters test mode when the TEST pin is pulled to 1.4 V above the VCC level. VCC must be 3.3 V.

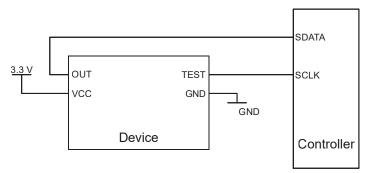


Figure 7: Programming Connections

Once the test mode is activated, the device expects 106 clock pulses on the TEST pin at the VCC voltage level or above, along with data on OUT. Those clock pulses should be separated by more than 1 μ s and less than 100 μ s. Data is read sequentially from the OUT pin upon each rising edge of TEST.

The fields for the data transmitted are:

- Key code (8 bits): should be 0b11110010; this prevents incorrect access
- OP code (2 bits):

OP Code	Description	OUT Operation	TEST Operation
0b00	Default operation	Analog output	Open drain digital output
0b01	Program (permanently burns fuses; cannot be undone)	Serial data input	SCLK input
0b10	Try (emulates a configuration without permanent change)	Serial data input	SCLK input
0b11	Read bits	Serial data output	SCLK output

- CTRL code (16 bits): controls the connections of multiplexers; leave at 0
- FBIT (80 bits): trimming bits for offset, sensitivity, and temperature compensation



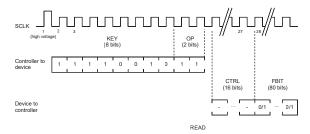
TIMING AND ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Min.	Тур.	Max.	Units
SDATA Setup Time to SCLK	T _{SETUP}	15	_	_	ns
SDATA Hold Time to SCLK	T_{HOLD}	50	_	_	ns
SCLK Rise Time	T _{R1}	_	_	50	ns
SCLK Fall Time	T _{F1}	_	_	50	ns
SCLK High Time	T _{HIGH1}	500 [1]	_	_	ns
SCLK Low Time	T _{LOW1}	500 [1]	_	_	ns
SCLK High Voltage (typical pulse level for a test sequence)	V _{HIGH1}	0.7 × V _{DD}	_	V _{DD} + 1.5	٧
SCLK High Voltage (the first pulse for a test sequence)	V _{HIGH1}	V _{DD} + 1.4	V _{DD} + 1.45	V _{DD} + 1.5	٧
SCLK Low Voltage	V_{LOW1}	-0.3	_	0.3 × V _{DD}	V
SDATA Rise Time	T _{R2}	_	_	50	ns
SDATA Fall Time	T _{F2}	_	-	50	ns
SDATA High Time	T _{H2}	500	-	_	ns
SDATA Low Time	T _{LOW2}	500	-	-	ns
SDATA High Voltage	V _{HIGH2}	0.7 × V _{DD}	-	V _{DD}	V
SDATA Low Voltage	V_{LOW2}	-0.3	_	0.3 × V _{DD}	V
Supply Voltage	V_{DD}	2.97	3.3	4	V

^[1] During programming, it should be greater than 2500 ns.

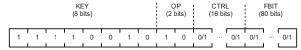
READ

After the device receives the correct KEY code and OP code = 0b11, it starts to output FBIT from the 28th SCLK pulse starting from FBIT[0]. The bits must be read on the descending edge of SCLK.



WRITE (VOLATILE)

After the device receives the correct KEY code and OP code = 0b01, if FBIT[76] is not set, update CTRL and FBIT with the received data.



To update only a part of FBIT, all other bits must be written as well. It might be needed to first read FBIT, then write it back with the relevant bits updated.

WRITE (PERMANENT)

After the device receives the correct KEY code and OP code = 0b10, if FBIT[76] is not set, update CTRL and permanently fuse FBIT with the previously volatile programmed data. The CTRL and FBIT data sent along with the fuse command are discarded. Cannot be undone.



TIME OUT

After a high-voltage pulse, the device returns to typical operation (timeout event) if:

- · An incorrect KEY code is received
- OP code = 0b00
- Two SCLK rising edges are separated by more than 100 μs.

Additional SCLK pulses after the 106 needed are discarded, but typical operation resumes only after timeout.



CT456

XtremeSense™ TMR Differential Contactless Current Sensor with Programmable Gain

BITS DESCRIPTION

Location	Name	Description	Bits	Factory Default
CTRL[0:16]	Control bits	Factory trimmed. Do not modify.	16	0x00
FBIT[0]	_	Factory trimmed. Do not modify.	1	0
FBIT[19:1]	_	Factory trimmed. Do not modify.	19	Trimmed
FBIT[27:20]	V_OS_MAG_LEFT	Trims the magnetic offset of the left AFE up/down.	8	0
FBIT[35:28]	V_OS_MAG_RIGHT	Trims the magnetic offset of the right AFE up/down.	8	0
FBIT[43:36]	V_OS_ELECT_LEFT	Trims the electronic offset of the left AFE up/down.	8	0
FBIT[51:44]	V_OS_ELECT_RIGHT	Trims the electronic offset of the right AFE up/down.	8	0
Bit[59:52]	GAIN_INSTR_AMPS_LEFT	Trims the gain of the left AFE up/down.	8	0
Bit[67:60]	GAIN_INSTR_AMPS_ RIGHT	Trims the gain of the right AFE up/down.	8	0
Bit[69:68]	_	Factory trimmed. Do not modify.	2	Trimmed
Bit[70]	GAIN_FOR_12MT	If Lo $ ightarrow$ 8 mT (20 A)/Hi $ ightarrow$ 12 mT (30 A) full-scale field.	1	0
Bit[79:71]	_	Factory trimmed. Do not modify.	9	Trimmed



FUNCTIONAL DESCRIPTION

Overview

The CT456 is a very-high-accuracy, contactless current sensor that can sense magnetic fields from 6 to 24 mT. The device has high sensitivity and a wide dynamic range with excellent accuracy across temperature.

The CT456 is also available in a user-programmable variant that enables end-of-line calibration of gain. While the sensor is pre-programmed to adjust sensitivity and offset temperature drift, the ability to adjust gain relaxes mechanical tolerances during sensor mounting.

When current is flowing through a busbar above or below the CT456, the XtremeSense TMR sensor inside the chip senses the field and generates corresponding differential voltage signals that then pass through the analog front-end (AFE) to output a current measurement.

The chip is designed to enable a fast response time of 300 ns for the current measurement from the OUT pin, as the bandwidth for the CT456 is 1 MHz. Even with a high bandwidth, the chip consumes a minimal amount of power.

Testing and Quality Assurance

Testing of the CT456 was conducted following AEC-Q100 standards to ensure reliability and performance in automotive conditions. During qualification, only the offset voltage error was tested at –40°C, 25°C, and 125°C. Sensitivity error was not checked directly during qualification but is estimated from qualification of similar packages.

Linear Output Current Measurement

The CT456 provides a continuous linear analog output voltage that represents the magnetic field generated by the current flowing through the busbar.

For the 5 V variant, the output voltage range of OUT is from 0.5 to 4.5 V with a $V_{\rm OQ}$ of 0.5 and 2.5 V for unidirectional and bidirectional fields, respectively. The output voltage range of the OUT pin as a function of the measured field is illustrated in Figure 8.

For the 3.3 V variant, the output voltage range of OUT is from 0.65 to 2.65 V with a V_{OO} of 0.65 and 1.65 V for unidirectional

and bidirectional fields, respectively. The output voltage range of the OUT pin as a function of the measured field is illustrated in Figure 9.

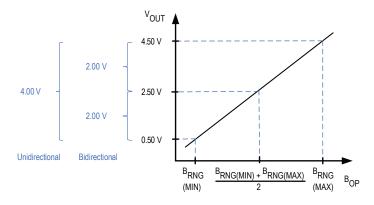


Figure 8: Linear Output Voltage Range (OUT) vs.

Measured Magnetic Field (B_{OP})

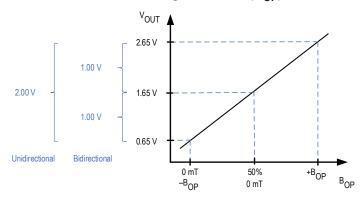


Figure 9: Linear Output Voltage Range (OUT) vs. Measured Magnetic Field (B_{OP})

Power-On Time (t_{ON})

Power-on time (t_{ON}) of 100 μ s is the amount of time required by CT456 to start up, fully power the chip, and become fully operational from the moment the supply voltage is greater than the UVLO voltage. This time includes the ramp-up time and the settling time (within 10% of steady-state voltage under an applied magnetic field) after the power supply has reached the minimum V_{CC} .



Response Time (t_{RESPONSE})

Response time ($t_{RESPONSE}$) is the period of time between:

- When the primary current signal reaches 90% of its final value, and
- 2. When the chip reaches 90% of its output corresponding to the applied current.

The CT456 has a response time of 300 ns.

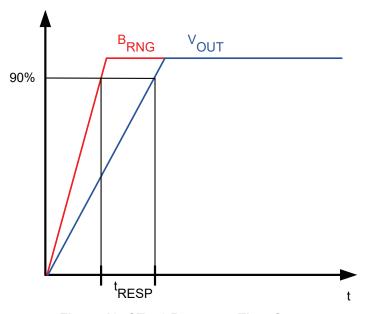


Figure 10: CT456 Response Time Curve

Rise Time (t_{RISE})

Rise time (t_{RISE}) is the period of time between when 10% and 90% of the full-scale output voltage is reached.

The CT456 has a rise time of 200 ns.

Propagation Delay (t_{DELAY})

Propagation delay (t_{DELAY}) is the period of time between:

- 1. When the primary current reaches 20% of its final value, and
- 2. When the chip reaches 20% of its output corresponding to the applied current.

The CT456 has a propagation delay of 250 ns.

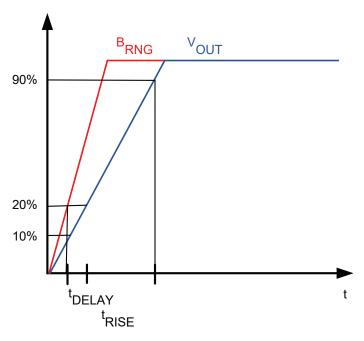


Figure 11: CT456 Propagation Delay and Rise Time Curve

Undervoltage Lockout (UVLO)

The undervoltage lockout protection circuitry of the CT456 is activated when the supply voltage (V_{CC}) reduces to less than 2.45 V. The CT456 remains in a low quiescent state until V_{CC} increases to greater than the UVLO threshold (2.5 V). In the condition where V_{CC} is less than 2.45 V and UVLO is triggered, the output from the CT456 is not valid. Once V_{CC} increases to greater than 2.5 V, the UVLO is cleared.

Current Sensing

The CT456 can sense and, therefore, measure the current by either placing a current-carrying busbar above or under the device. The chip is also sensitive enough to measure the current from a PCB trace that is routed beneath it.

Bypass Capacitor

A single 1 μ F capacitor is needed for the VCC pin to reduce the noise from the power supply and other circuits. This capacitor should be placed as close as practical to the CT456 to minimize inductance and resistance between the two devices.



XtremeSense TMR Current Sensor Location

The XtremeSense TMR current sensor location of the CT456 is shown in the figure that follows. All dimensions in the figures are nominal.

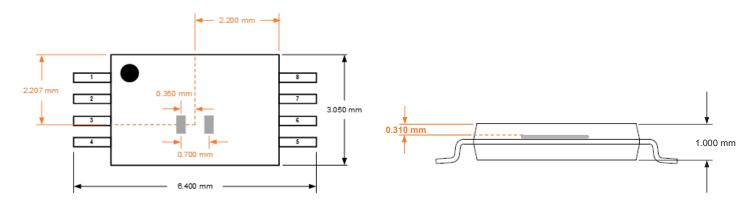


Figure 12: XtremeSense TMR Current Sensor Location in x-y Plane for CT456 in TSSOP-8 Package

Figure 13: XtremeSense TMR Current Sensor Location in z Dimension for CT456 in TSSOP-8 Package

PACKAGE OUTLINE DRAWINGS

For Reference Only - Not for Tooling Use

Dimensions in millimeters - NOT TO SCALE

Dimensions exclusive of mold flash, gate burs, and dambar protrusions Exact case and lead configuration at supplier discretion within limits shown

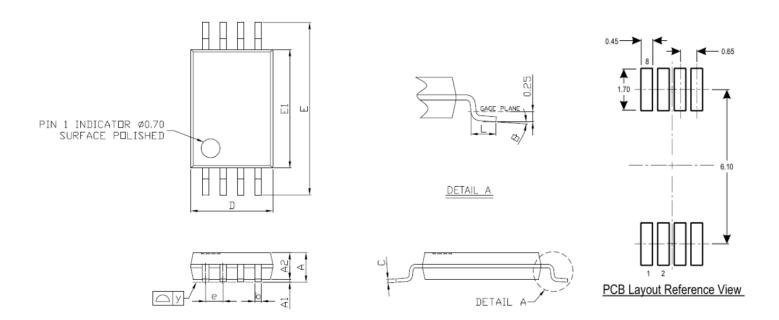


Figure 14: TSSOP-8 Package Drawing and Dimensions

Table 1: CT456 TSSOP-8 Package Dimensions

Symbol	Dimensions in Millimeters (mm)		
	Min.	Тур.	Max.
Α	1.05	1.10	1.20
A1	0.05	0.10	0.15
A2	_	1.00	1.05
b	0.25	_	0.30
С	_	0.127	-
D	2.90	3.05	3.10
E	6.20	6.40	6.60
E1	4.30	4.40	4.50
е	_	0.65	_
L	0.50	0.60	0.70
у	_	-	0.076
θ	0°	4°	8°



TAPE AND REEL POCKET DRAWINGS AND DIMENSIONS

For Reference Only – Not for Tooling Use

Dimensions in millimeters – NOT TO SCALE

Dimensions exclusive of mold flash, gate burs, and dambar protrusions

Exact case and lead configuration at supplier discretion within limits shown

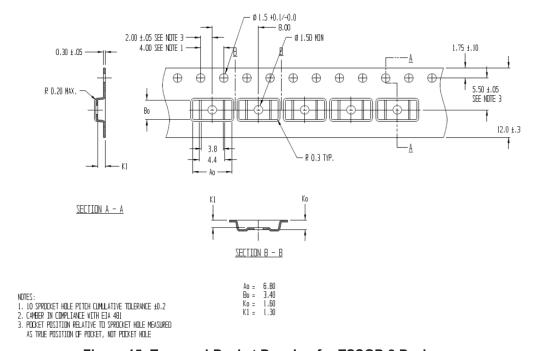


Figure 15: Tape-and-Pocket Drawing for TSSOP-8 Package

DEVICE MARKINGS



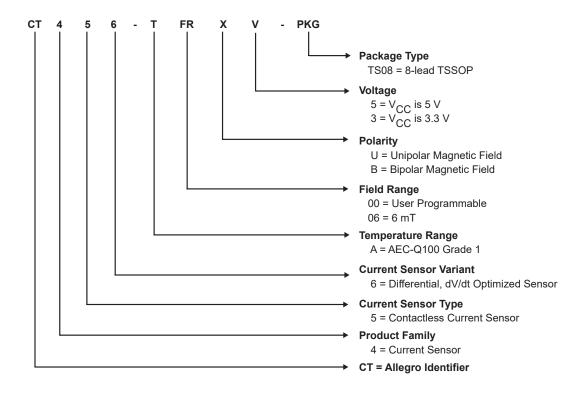
Figure 16: CT456 Device Marking for 8-Lead TSSOP Package

Table 2: CT456 Device Marking Definition for 8-Lead TSSOP Package

Row No.	Code	Definition	
1	•	Pin 1 Indicator	
2	CT456	Allegro Part Number	
3	XX	Maximum Magnetic Field Rating	
3	В	Sensing Polarity	
3	V	Supply Voltage	
4	YY	Calendar Year	
4	WW	Work Week	
4	LL	Lot Code	



PART ORDERING NUMBER LEGEND





CT456

XtremeSense™ TMR Differential Contactless Current Sensor with Programmable Gain

Revision History

Number	Date	Description
2	November 2, 2023	Document rebranded and minor editorial updates
3	February 29, 2024	Removed AEC-Q100 (pages 1, 2, 15); updated Offset Voltage (page 8); removed Out Accuracy Performance footnotes (pages 7-8); updated Sensitivity and removed Noise (page 8)
4	March 20, 2024	Updated Features and Benefits (page 1), Figure 3 and Terminal List (page 4)
5	July 29, 2024	Major overhaul to reflect automotive-qualified part per details provided in the new Testing and Quality Assurance section: changed user-programmable field range (page 1), preset magnetic field ranges (page 1) and all part numbers in the selection guide (page 2); removed evaluation board selection guide (page 2) and recommended external components table (page 4); changed application diagram (page 4) and electrical characteristics symbols for OUT capacitive load and OUT resistive load (page 6); removed voltage output quiescent and lifetime drift characteristics (page 6) and bandwidth performance plot (page 7); replaced device-specific electrical characteristic tables (pages 8 through 11); added Device Programming section (pages 12 through 14), Testing and Quality Assurance section (page 15), and 3.3 variant information in the Linear Output Current Measurement section (page 15); replaced current sensor position images (page 17); added PCB layout drawing (page 18); updated Device Markings section (page 20) and Part Ordering Number Legend section (page 21); and made minor editorial changes throughout (all pages), including removal of trailing zeros, reformatting of some images for readability (larger text), removal of archaic language (normal changed to typical), and minimization of the use of title case.
6	August 7, 2024	Updated Description (page 1); updated Device Programming Communication table (page 12); updated Device Markings section (page 20)
7	October 14, 2024	Updated Features and Benefits (page 1); updated and Selection Guide (page 2); modified programmable magnetic field range (pages 1, 2, 9, 10, 11, and 15); modified noise operating characteristic (pages 8–11), description and timing diagram for read operation (page 13), and XtremeSense TMR current sensor location diagram (page 7); made minor editorial changes throughout.

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